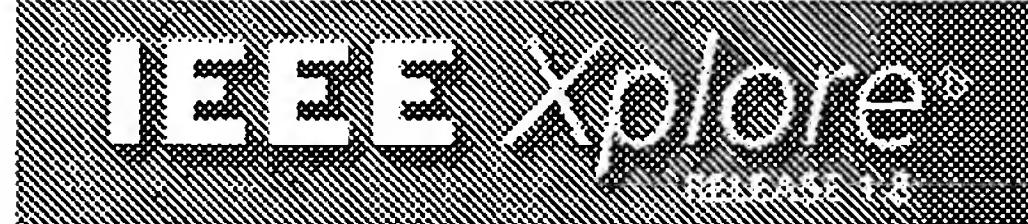


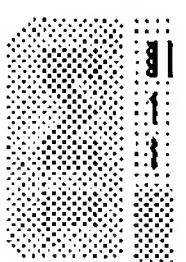
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```
(starter<or>starting)
<paragraph>sensor<paragraph>ba
ttery<and>
(install<or>installed<or>insta
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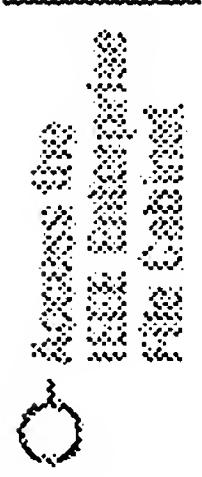
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